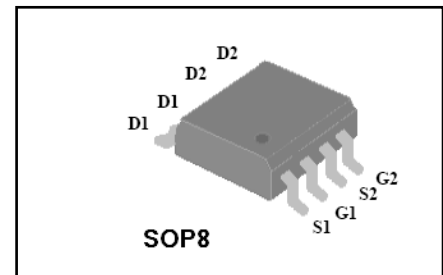
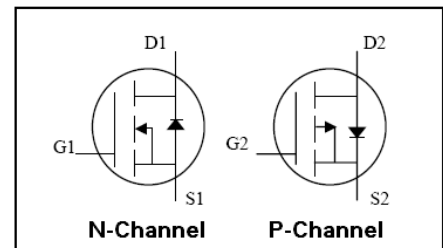


**Features**

- ◆ N-CH: 60V/8A,  $R_{DS(ON)}=35m\Omega$
- ◆ P-CH: -60V/-7.5A,  $R_{DS(ON)}=75m\Omega$
- ◆ Low On-Resistance
- ◆ 150°C Operating Temperature
- ◆ Fast Switching
- ◆ Lead-Free, Green Product

**Description**

VS4559AS designed by the trench processing techniques to achieve extremely low on-resistance. And fast switching speed and improved transfer effective . These features combine to make this design an extremely efficient and reliable device for variety of DC-DC applications.

**Pin Description**

**Absolute Maximum Ratings**

Symbol	Parameter	Rating		Unit	
		NMOS	PMOS		
<b>Common Ratings (<math>T_c=25^\circ\text{C}</math> Unless Otherwise Noted)</b>					
$V_{GS}$	Gate-Source Voltage	±60	±60	V	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	60	-60	V	
$T_J$	Maximum Junction Temperature	175		°C	
$T_{STG}$	Storage Temperature Range	-50 to 150		°C	
$I_S$	Diode Continuous Forward Current <sup>①</sup>	$T_c=25^\circ\text{C}$	8	-7.5	A
<b>Mounted on Large Heat Sink</b>					
$I_{DM}$	Pulse Drain Current Tested <sup>②</sup>	$T_c=25^\circ\text{C}$	28	-27	A
$I_D$	Continuous Drain Current( $V_{GS}=-10\text{V}$ )	$T_c=25^\circ\text{C}$	8	-7.5	A
		$T_c=100^\circ\text{C}$	5.5	-5	
$P_D$	Maximum Power Dissipation	$T_c=25^\circ\text{C}$	2		W
$R_{\theta JA}$	Thermal Resistance Junction-Ambient	62.5		°C/W	

N-Channel

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	60	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (T <sub>c</sub> =25°C)	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V	--	--	1	μA
	Zero Gate Voltage Drain Current (T <sub>c</sub> =125°C)	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V	--	--	100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	--	--	±100	nA
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	2.0	3.0	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =8A	--	35	50	mΩ
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =4A	--	55	70	mΩ
<b>Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, f=1MHz	--	750	--	pF
C <sub>oss</sub>	Output Capacitance		--	155	--	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	48	--	pF
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =30V, I <sub>D</sub> =4A, V <sub>GS</sub> =4.5V	--	20	--	nC
Q <sub>gs</sub>	GateSource Charge		--	11	--	nC
Q <sub>gd</sub>	GateDrain Charge		--	8	--	nC
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turnon Delay Time	V <sub>DD</sub> =30V, I <sub>D</sub> =6A, R <sub>G</sub> =3.3Ω, V <sub>GS</sub> =10V	--	15	--	nS
t <sub>r</sub>	Turnon Rise Time		--	19	--	nS
t <sub>d(off)</sub>	TurnOff Delay Time		-	30	--	nS
t <sub>f</sub>	TurnOff Fall Time		--	13	--	nS
<b>Source Drain Diode Characteristics</b>						
I <sub>SD</sub>	Sourcedrain current(Body Diode) <sup>①</sup>	T <sub>c</sub> =25°C	8	--	--	A
V <sub>SD</sub>	Forward on voltage	T <sub>J</sub> =25°C, I <sub>SD</sub> =4A, V <sub>GS</sub> =0V	--	0.82	1.2	V

Notes:

- ① Pulse test ; Pulse width ≤ 300μs, duty cycle ≤ 2%.
- ② Pulse width limited by maximum allowable junction temperature

P-Channel

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-60	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (T <sub>c</sub> =25°C)	V <sub>DS</sub> =-48V, V <sub>GS</sub> =0V	--	--	1	μA
	Zero Gate Voltage Drain Current (T <sub>c</sub> =125°C)	V <sub>DS</sub> =-48V, V <sub>GS</sub> =0V	--	--	100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	--	--	±100	nA
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-1.0	-2.0	-3.0	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-6A	--	75	95	mΩ
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A	--	95	110	mΩ
<b>Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V, f=1MHz	--	750	--	pF
C <sub>oss</sub>	Output Capacitance		--	95	--	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	50	--	pF
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-30V, I <sub>D</sub> =-6A, V <sub>GS</sub> =-4.5V	--	19	--	nC
Q <sub>gs</sub>	Gate-Source Charge		--	12	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	6	--	nC
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =-30V, I <sub>D</sub> =-6A, R <sub>G</sub> =3.3Ω, V <sub>GS</sub> =-4.5V	--	8.5	--	nS
t <sub>r</sub>	Turn-on Rise Time		--	14	--	nS
t <sub>d(off)</sub>	Turn-Off Delay Time		--	21	--	nS
t <sub>f</sub>	Turn-Off Fall Time		--	15	--	nS
<b>Source- Drain Diode Characteristics</b>						
I <sub>SD</sub>	Source-drain current(Body Diode)	T <sub>c</sub> =25°C	-7.8 <sup>①</sup>	--	--	A
V <sub>SD</sub>	Forward on voltage	T <sub>J</sub> =25°C, I <sub>SD</sub> =-4A V <sub>GS</sub> =0V	--	-0.83	-1.2	V

Notes:

- ① Pulse test ; Pulse width≤300μs, duty cycle≤2%.
- ② Pulse width limited by maximum allowable junction temperature.

N-Channel Typical Characteristics

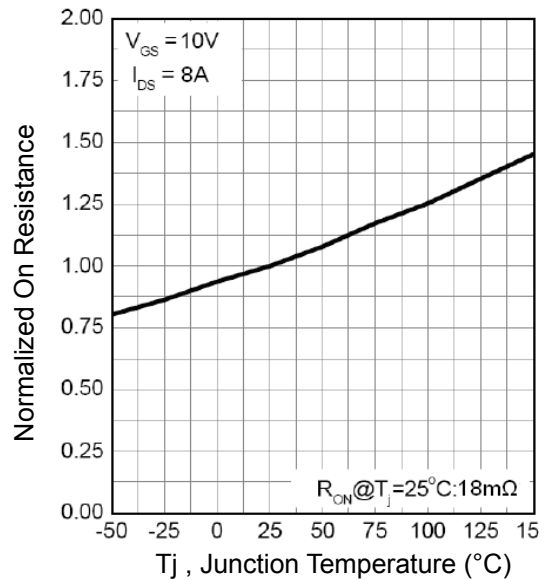
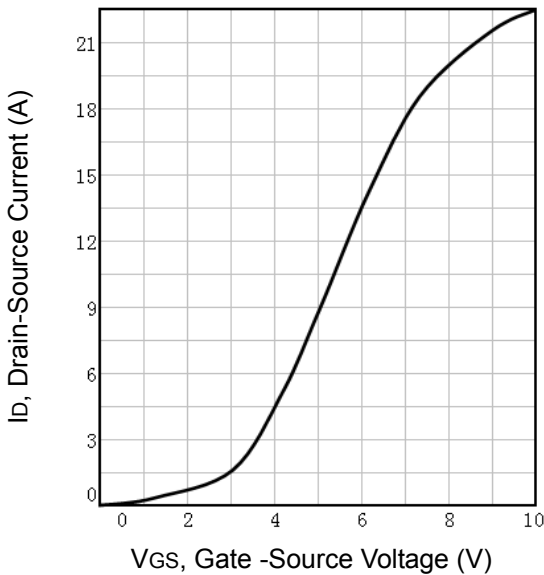
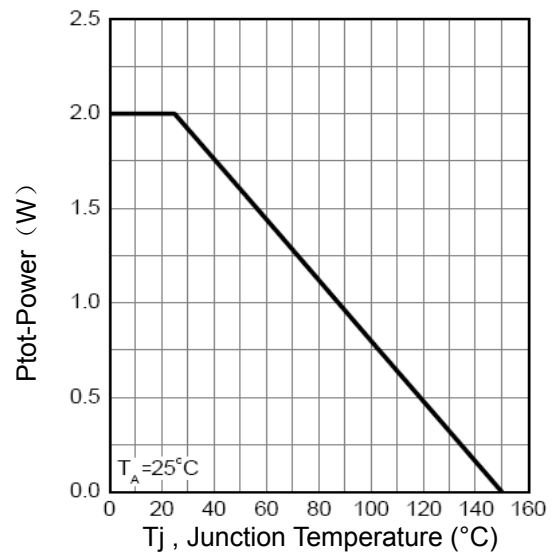
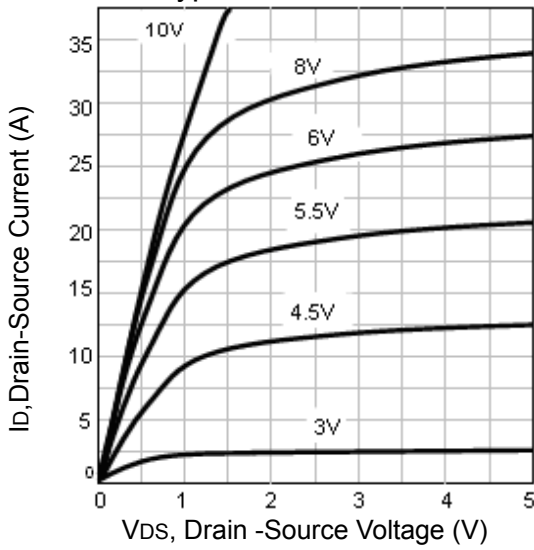


Fig3. Typical Transfer Characteristics

Fig4. Normalized On-Resistance Vs. Temperature

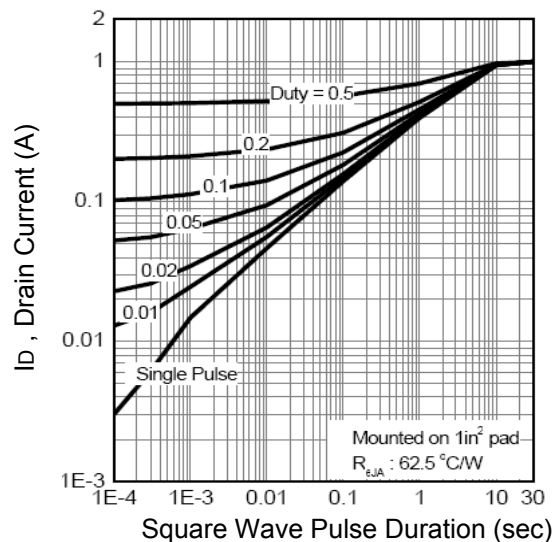
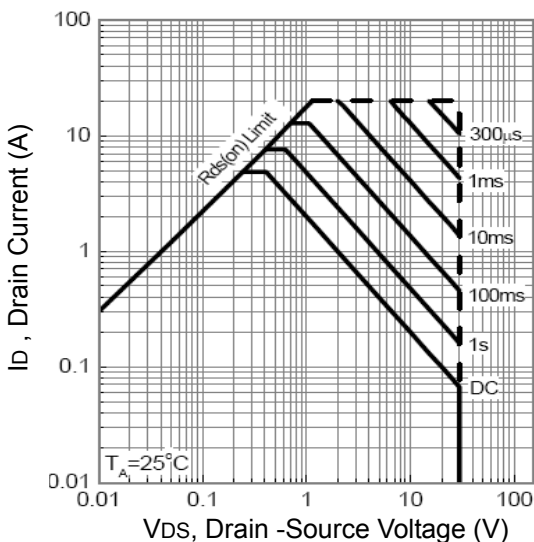


Fig5. Maximum Safe Operating Area

Fig6. Thermal Transient Impedance

N-Channel Typical Characteristics

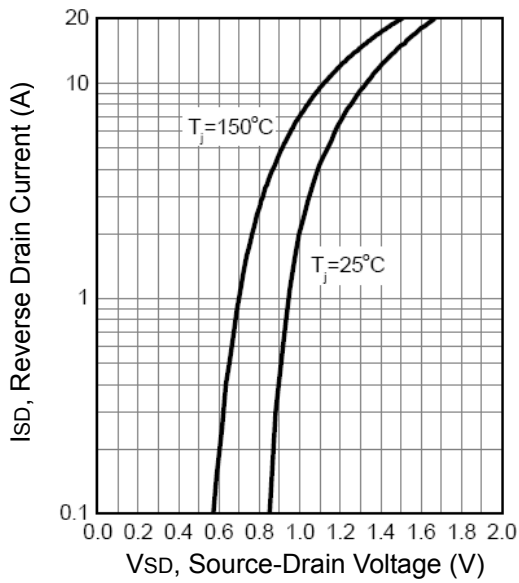


Fig7. Typical Source-Drain Diode Forward Voltage

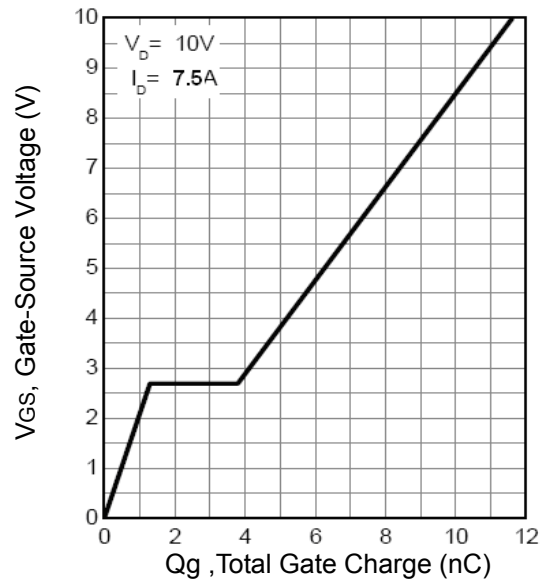


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

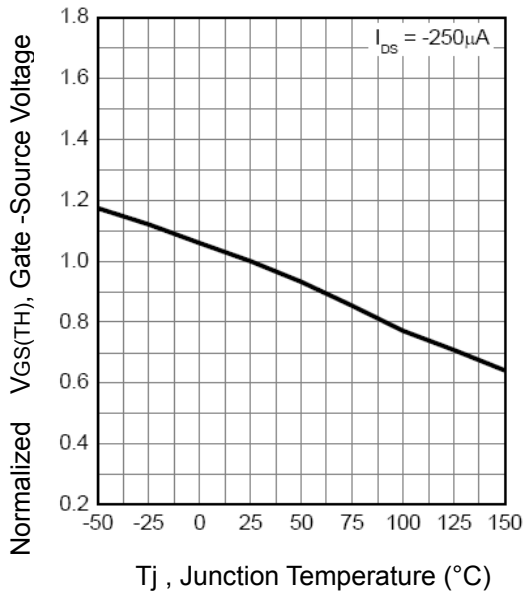


Fig9. Threshold Voltage Vs. Temperature

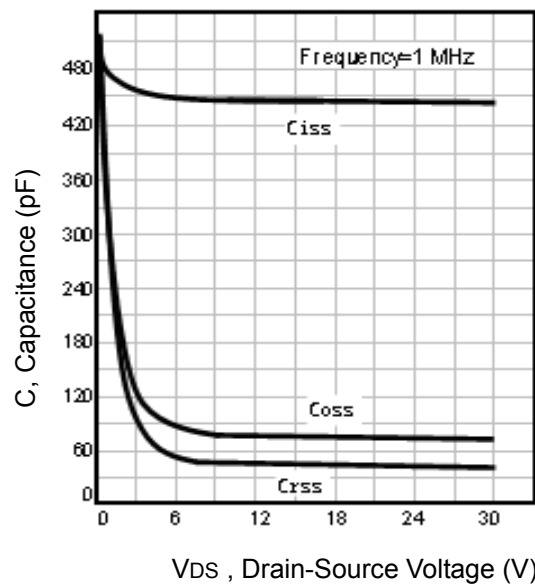


Fig10. Typical Capacitance Vs. Drain-Source Voltage

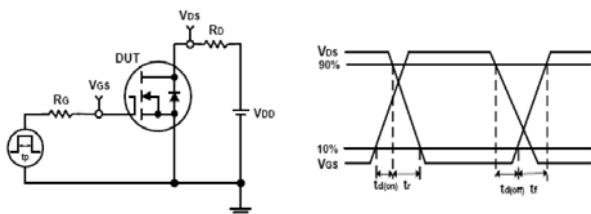


Fig11. Switching Time Test Circuit and waveforms

P-Channel Typical Characteristics

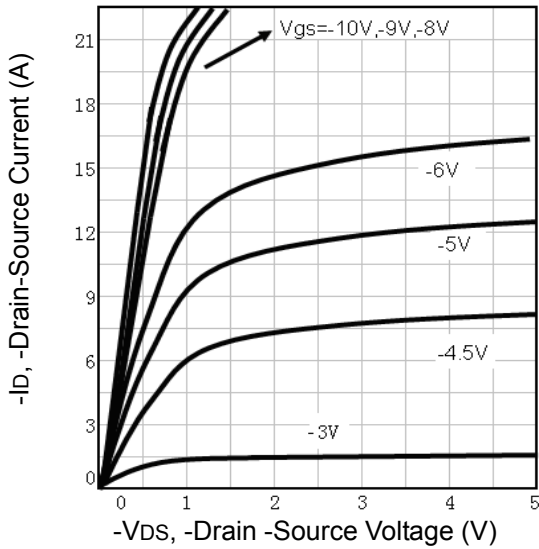


Fig1. Typical Output Characteristics

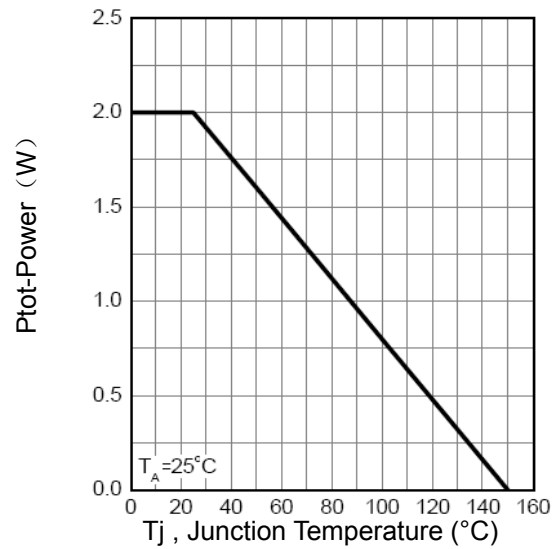


Fig2. Power Dissipation

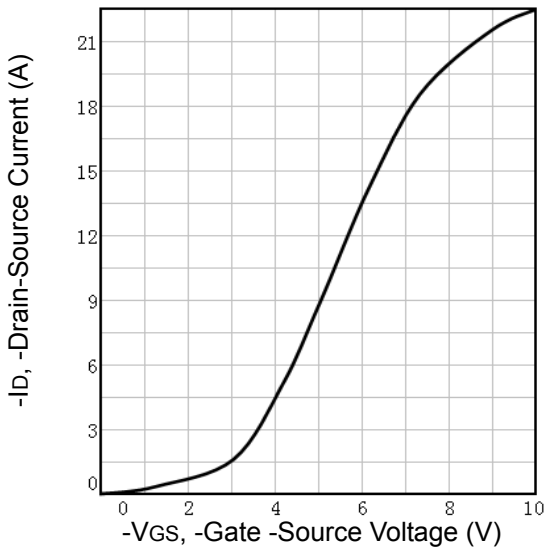


Fig3. Typical Transfer Characteristics

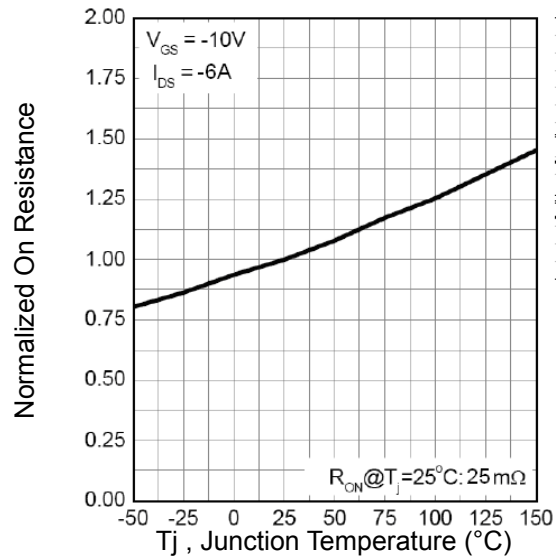


Fig4. Normalized On-Resistance Vs. Temperature

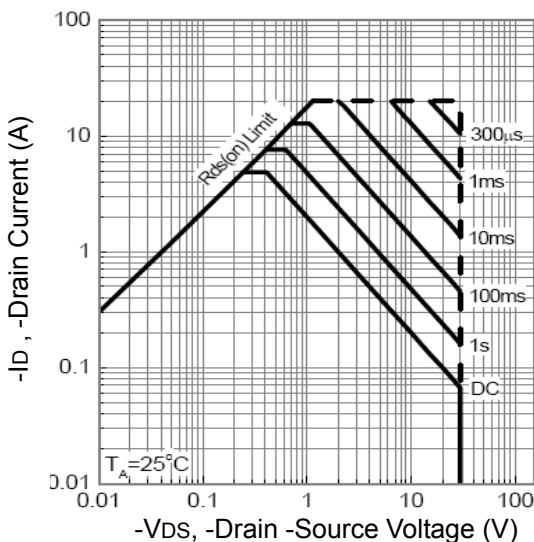


Fig5. Maximum Safe Operating Area

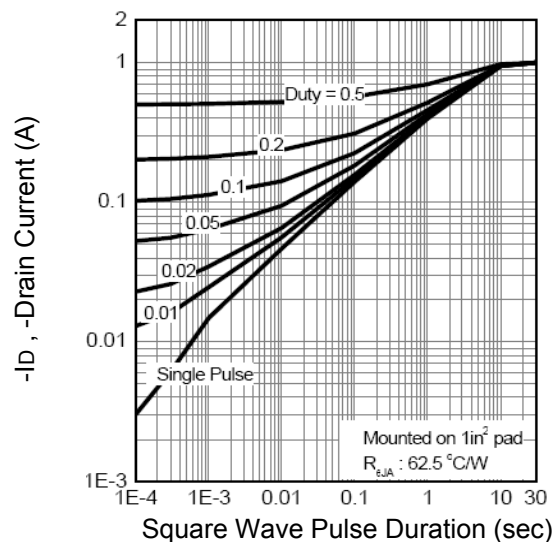


Fig6. Thermal Transient Impedance

P-Channel Typical Characteristics

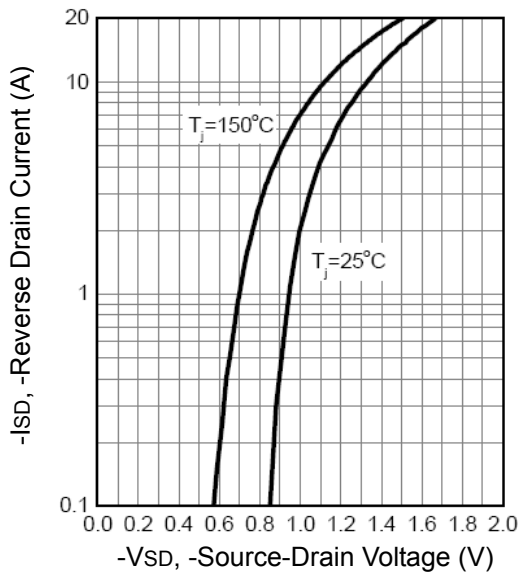


Fig7. Typical Source-Drain Diode Forward Voltage

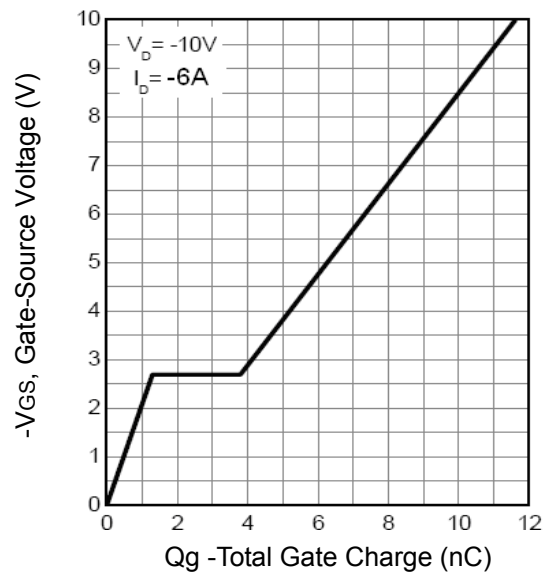


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

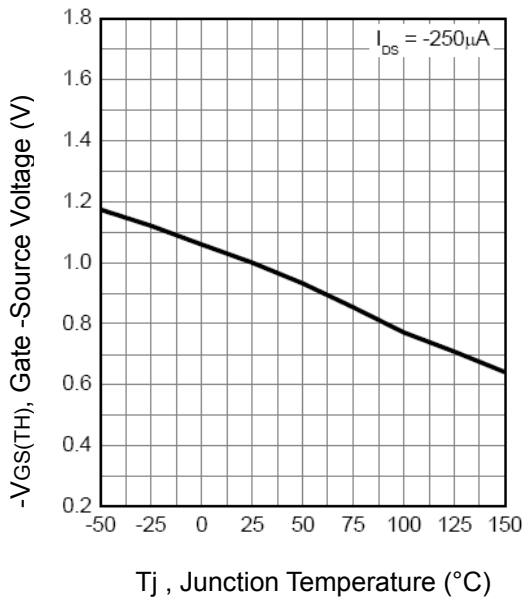


Fig9. Threshold Voltage Vs. Temperature

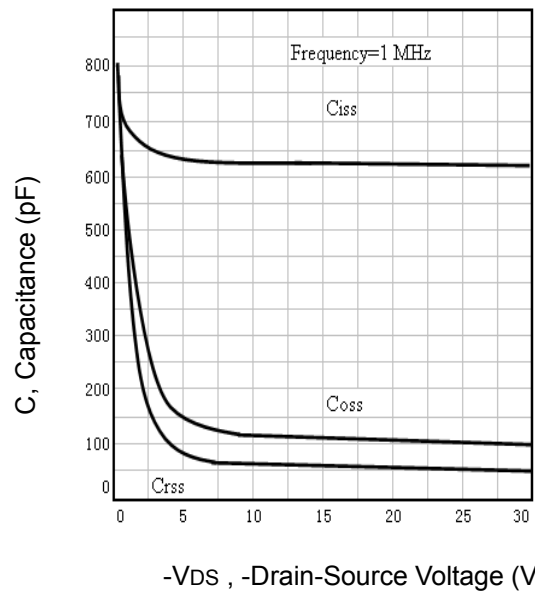


Fig10. Typical Capacitance Vs. Drain-Source Voltage

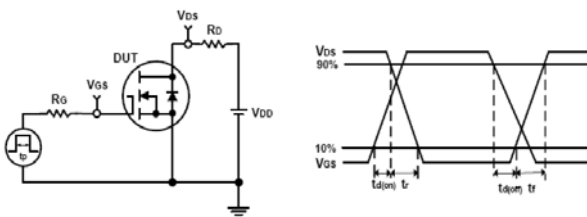
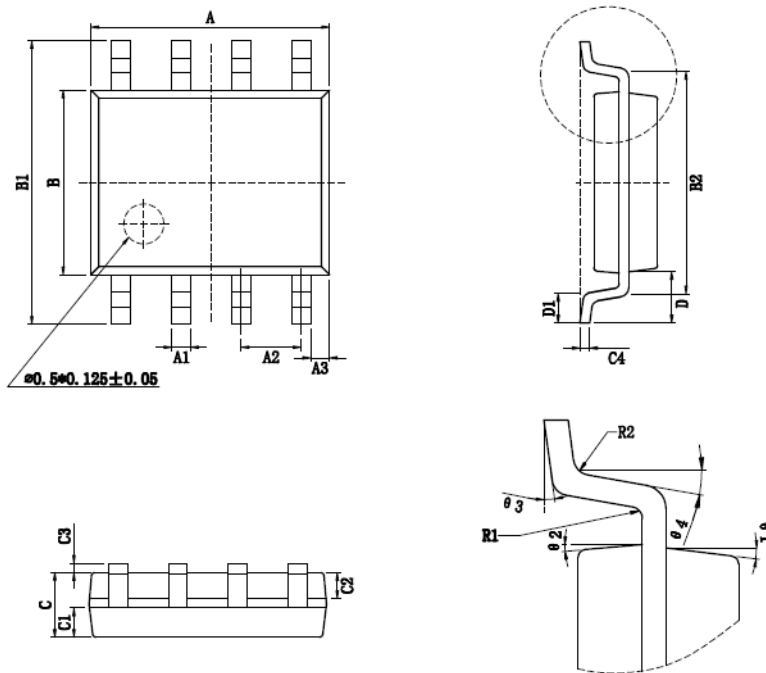


Fig11. Switching Time Test Circuit and waveforms

**SOP8 Mechanical Data**



Symbol	Dimensions In Millimeters		
	Min	Nom	Max
A	4.800	4.900	5.000
A1	0.356	0.406	0.456
A2	1.270Typ.		
A3	0.345Typ.		
B	3.800	3.900	4.000
B1	5.800	6.000	6.200
B2	5.00Typ.		
C	1.300	1.400	1.500
C1	0.550	0.600	0.650
C2	0.550	0.600	0.650
C3	0.050	--	0.200
C4	0.203Typ.		
D	1.050Typ.		
D1	0.400	0.500	0.600
R1	0.200Typ.		
R2	0.200Typ.		
θ1	17°Typ.		
θ2	13°Typ.		
θ3	0~ 8°Typ.		
θ4	4~ 12°Typ.		

**Order Information**

Product	Marking	Package	Packaging	Min Unit Quantity
VS4559MS	VS4559MS	SOP8	3000/Reel	6000

**Customer Service**

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